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Understanding [Embedded - FPGAs \(Field Programmable Gate Array\)](#)

Embedded - FPGAs, or Field Programmable Gate Arrays, are advanced integrated circuits that offer unparalleled flexibility and performance for digital systems. Unlike traditional fixed-function logic devices, FPGAs can be programmed and reprogrammed to execute a wide array of logical operations, enabling customized functionality tailored to specific applications. This reprogrammability allows developers to iterate designs quickly and implement complex functions without the need for custom hardware.

Applications of Embedded - FPGAs

The versatility of Embedded - FPGAs makes them indispensable in numerous fields. In telecommunications.

Details

| | |
|--------------------------------|---|
| Product Status | Obsolete |
| Number of LABs/CLBs | 1176 |
| Number of Logic Elements/Cells | 5292 |
| Total RAM Bits | 57344 |
| Number of I/O | 140 |
| Number of Gates | 200000 |
| Voltage - Supply | 2.375V ~ 2.625V |
| Mounting Type | Surface Mount |
| Operating Temperature | -40°C ~ 100°C (TJ) |
| Package / Case | 208-BFQFP |
| Supplier Device Package | 208-PQFP (28x28) |
| Purchase URL | https://www.e-xfl.com/product-detail/xilinx/xc2s200-5pq208i |

Introduction

The Spartan®-II Field-Programmable Gate Array family gives users high performance, abundant logic resources, and a rich feature set, all at an exceptionally low price. The six-member family offers densities ranging from 15,000 to 200,000 system gates, as shown in [Table 1](#). System performance is supported up to 200 MHz. Features include block RAM (to 56K bits), distributed RAM (to 75,264 bits), 16 selectable I/O standards, and four DLLs. Fast, predictable interconnect means that successive design iterations continue to meet timing requirements.

The Spartan-II family is a superior alternative to mask-programmed ASICs. The FPGA avoids the initial cost, lengthy development cycles, and inherent risk of conventional ASICs. Also, FPGA programmability permits design upgrades in the field with no hardware replacement necessary (impossible with ASICs).

Features

- Second generation ASIC replacement technology
 - Densities as high as 5,292 logic cells with up to 200,000 system gates
 - Streamlined features based on Virtex® FPGA architecture
 - Unlimited reprogrammability
 - Very low cost
 - Cost-effective 0.18 micron process
- System level features
 - SelectRAM™ hierarchical memory:
 - 16 bits/LUT distributed RAM
 - Configurable 4K bit block RAM
 - Fast interfaces to external RAM
 - Fully PCI compliant
 - Low-power segmented routing architecture
 - Full readback ability for verification/observability
 - Dedicated carry logic for high-speed arithmetic
 - Efficient multiplier support
 - Cascade chain for wide-input functions
 - Abundant registers/latches with enable, set, reset
 - Four dedicated DLLs for advanced clock control
 - Four primary low-skew global clock distribution nets
 - IEEE 1149.1 compatible boundary scan logic
- Versatile I/O and packaging
 - Pb-free package options
 - Low-cost packages available in all densities
 - Family footprint compatibility in common packages
 - 16 high-performance interface standards
 - Hot swap Compact PCI friendly
 - Zero hold time simplifies system timing
- Core logic powered at 2.5V and I/Os powered at 1.5V, 2.5V, or 3.3V
- Fully supported by powerful Xilinx® ISE® development system
 - Fully automatic mapping, placement, and routing

Table 1: Spartan-II FPGA Family Members

| Device | Logic Cells | System Gates (Logic and RAM) | CLB Array (R x C) | Total CLBs | Maximum Available User I/O ⁽¹⁾ | Total Distributed RAM Bits | Total Block RAM Bits |
|---------|-------------|------------------------------|-------------------|------------|---|----------------------------|----------------------|
| XC2S15 | 432 | 15,000 | 8 x 12 | 96 | 86 | 6,144 | 16K |
| XC2S30 | 972 | 30,000 | 12 x 18 | 216 | 92 | 13,824 | 24K |
| XC2S50 | 1,728 | 50,000 | 16 x 24 | 384 | 176 | 24,576 | 32K |
| XC2S100 | 2,700 | 100,000 | 20 x 30 | 600 | 176 | 38,400 | 40K |
| XC2S150 | 3,888 | 150,000 | 24 x 36 | 864 | 260 | 55,296 | 48K |
| XC2S200 | 5,292 | 200,000 | 28 x 42 | 1,176 | 284 | 75,264 | 56K |

Notes:

1. All user I/O counts do not include the four global clock/user input pins. See details in [Table 2, page 4](#).

The three IOB registers function either as edge-triggered D-type flip-flops or as level-sensitive latches. Each IOB has a clock signal (CLK) shared by the three registers and independent Clock Enable (CE) signals for each register. In addition to the CLK and CE control signals, the three registers share a Set/Reset (SR). For each register, this signal can be independently configured as a synchronous Set, a synchronous Reset, an asynchronous Preset, or an asynchronous Clear.

A feature not shown in the block diagram, but controlled by the software, is polarity control. The input and output buffers and all of the IOB control signals have independent polarity controls.

Optional pull-up and pull-down resistors and an optional weak-keeper circuit are attached to each pad. Prior to configuration all outputs not involved in configuration are forced into their high-impedance state. The pull-down resistors and the weak-keeper circuits are inactive, but inputs may optionally be pulled up.

Table 3: Standards Supported by I/O (Typical Values)

| I/O Standard | Input Reference Voltage (V_{REF}) | Output Source Voltage (V_{CCO}) | Board Termination Voltage (V_{TT}) |
|----------------------------|---------------------------------------|-------------------------------------|--|
| LVTTTL (2-24 mA) | N/A | 3.3 | N/A |
| LVC MOS2 | N/A | 2.5 | N/A |
| PCI (3V/5V, 33 MHz/66 MHz) | N/A | 3.3 | N/A |
| GTL | 0.8 | N/A | 1.2 |
| GTL+ | 1.0 | N/A | 1.5 |
| HSTL Class I | 0.75 | 1.5 | 0.75 |
| HSTL Class III | 0.9 | 1.5 | 1.5 |
| HSTL Class IV | 0.9 | 1.5 | 1.5 |
| SSTL3 Class I and II | 1.5 | 3.3 | 1.5 |
| SSTL2 Class I and II | 1.25 | 2.5 | 1.25 |
| CTT | 1.5 | 3.3 | 1.5 |
| AGP-2X | 1.32 | 3.3 | N/A |

The activation of pull-up resistors prior to configuration is controlled on a global basis by the configuration mode pins. If the pull-up resistors are not activated, all the pins will float. Consequently, external pull-up or pull-down resistors must be provided on pins required to be at a well-defined logic level prior to configuration.

All pads are protected against damage from electrostatic discharge (ESD) and from over-voltage transients. Two forms of over-voltage protection are provided, one that permits 5V compliance, and one that does not. For 5V compliance, a zener-like structure connected to ground turns on when the output rises to approximately 6.5V. When 5V compliance is not required, a conventional clamp diode may be connected to the output supply voltage, V_{CCO} . The type of over-voltage protection can be selected independently for each pad.

All Spartan-II FPGA IOBs support IEEE 1149.1-compatible boundary scan testing.

Input Path

A buffer in the Spartan-II FPGA IOB input path routes the input signal either directly to internal logic or through an optional input flip-flop.

An optional delay element at the D-input of this flip-flop eliminates pad-to-pad hold time. The delay is matched to the internal clock-distribution delay of the FPGA, and when used, assures that the pad-to-pad hold time is zero.

Each input buffer can be configured to conform to any of the low-voltage signaling standards supported. In some of these standards the input buffer utilizes a user-supplied threshold voltage, V_{REF} . The need to supply V_{REF} imposes constraints on which standards can be used in close proximity to each other. See "[I/O Banking](#)," page 9.

There are optional pull-up and pull-down resistors at each input for use after configuration.

Output Path

The output path includes a 3-state output buffer that drives the output signal onto the pad. The output signal can be routed to the buffer directly from the internal logic or through an optional IOB output flip-flop.

The 3-state control of the output can also be routed directly from the internal logic or through a flip-flop that provides synchronous enable and disable.

Each output driver can be individually programmed for a wide range of low-voltage signaling standards. Each output buffer can source up to 24 mA and sink up to 48 mA. Drive strength and slew rate controls minimize bus transients.

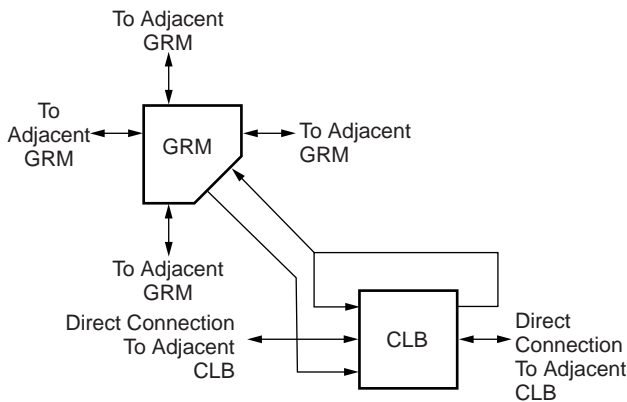
In most signaling standards, the output high voltage depends on an externally supplied V_{CCO} voltage. The need to supply V_{CCO} imposes constraints on which standards can be used in close proximity to each other. See "[I/O Banking](#)".

An optional weak-keeper circuit is connected to each output. When selected, the circuit monitors the voltage on the pad and weakly drives the pin High or Low to match the input signal. If the pin is connected to a multiple-source signal, the weak keeper holds the signal in its last state if all

Local Routing

The local routing resources, as shown in Figure 6, provide the following three types of connections:

- Interconnections among the LUTs, flip-flops, and General Routing Matrix (GRM)
- Internal CLB feedback paths that provide high-speed connections to LUTs within the same CLB, chaining them together with minimal routing delay
- Direct paths that provide high-speed connections between horizontally adjacent CLBs, eliminating the delay of the GRM



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Figure 6: Spartan-II Local Routing

General Purpose Routing

Most Spartan-II FPGA signals are routed on the general purpose routing, and consequently, the majority of interconnect resources are associated with this level of the routing hierarchy. The general routing resources are located in horizontal and vertical routing channels associated with the rows and columns CLBs. The general-purpose routing resources are listed below.

- Adjacent to each CLB is a General Routing Matrix (GRM). The GRM is the switch matrix through which horizontal and vertical routing resources connect, and is also the means by which the CLB gains access to the general purpose routing.
- 24 single-length lines route GRM signals to adjacent GRMs in each of the four directions.
- 96 buffered Hex lines route GRM signals to other GRMs six blocks away in each one of the four directions. Organized in a staggered pattern, Hex lines may be driven only at their endpoints. Hex-line signals can be accessed either at the endpoints or at the midpoint (three blocks from the source). One third of the Hex lines are bidirectional, while the remaining ones are unidirectional.
- 12 Longlines are buffered, bidirectional wires that distribute signals across the device quickly and

efficiently. Vertical Longlines span the full height of the device, and horizontal ones span the full width of the device.

I/O Routing

Spartan-II devices have additional routing resources around their periphery that form an interface between the CLB array and the IOBs. This additional routing, called the VersaRing, facilitates pin-swapping and pin-locking, such that logic redesigns can adapt to existing PCB layouts. Time-to-market is reduced, since PCBs and other system components can be manufactured while the logic design is still in progress.

Dedicated Routing

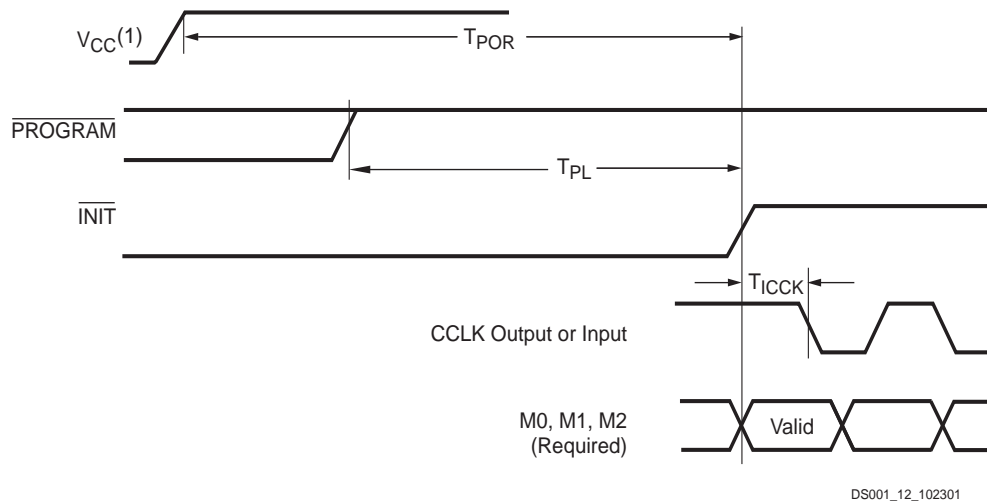
Some classes of signal require dedicated routing resources to maximize performance. In the Spartan-II architecture, dedicated routing resources are provided for two classes of signal.

- Horizontal routing resources are provided for on-chip 3-state busses. Four partitionable bus lines are provided per CLB row, permitting multiple busses within a row, as shown in Figure 7.
- Two dedicated nets per CLB propagate carry signals vertically to the adjacent CLB.

Global Routing

Global Routing resources distribute clocks and other signals with very high fanout throughout the device. Spartan-II devices include two tiers of global routing resources referred to as primary and secondary global routing resources.

- The primary global routing resources are four dedicated global nets with dedicated input pins that are designed to distribute high-fanout clock signals with minimal skew. Each global clock net can drive all CLB, IOB, and block RAM clock pins. The primary global nets may only be driven by global buffers. There are four global buffers, one for each global net.
- The secondary global routing resources consist of 24 backbone lines, 12 across the top of the chip and 12 across bottom. From these lines, up to 12 unique signals per column can be distributed via the 12 longlines in the column. These secondary resources are more flexible than the primary resources since they are not restricted to routing only to clock pins.



| Symbol | Description | Min | Max |
|---------------|---|-------------|-------------|
| T_{POR} | Power-on reset | - | 2 ms |
| T_{PL} | Program latency | - | 100 μ s |
| T_{ICCK} | CCLK output delay (Master Serial mode only) | 0.5 μ s | 4 μ s |
| $T_{PROGRAM}$ | Program pulse width | 300 ns | - |

Notes: (referring to waveform above:)

1. Before configuration can begin, V_{CCINT} must be greater than 1.6V and V_{CCO} Bank 2 must be greater than 1.0V.

Figure 12: Configuration Timing on Power-Up

Clearing Configuration Memory

The device indicates that clearing the configuration memory is in progress by driving \overline{INIT} Low. At this time, the user can delay configuration by holding either $\overline{PROGRAM}$ or \overline{INIT} Low, which causes the device to remain in the memory clearing phase. Note that the bidirectional \overline{INIT} line is driving a Low logic level during memory clearing. To avoid contention, use an open-drain driver to keep \overline{INIT} Low.

With no delay in force, the device indicates that the memory is completely clear by driving \overline{INIT} High. The FPGA samples its mode pins on this Low-to-High transition.

Loading Configuration Data

Once \overline{INIT} is High, the user can begin loading configuration data frames into the device. The details of loading the configuration data are discussed in the sections treating the configuration modes individually. The sequence of operations necessary to load configuration data using the serial modes is shown in Figure 14. Loading data using the Slave Parallel mode is shown in Figure 19, page 25.

CRC Error Checking

During the loading of configuration data, a CRC value embedded in the configuration file is checked against a CRC value calculated within the FPGA. If the CRC values

do not match, the FPGA drives \overline{INIT} Low to indicate that a frame error has occurred and configuration is aborted.

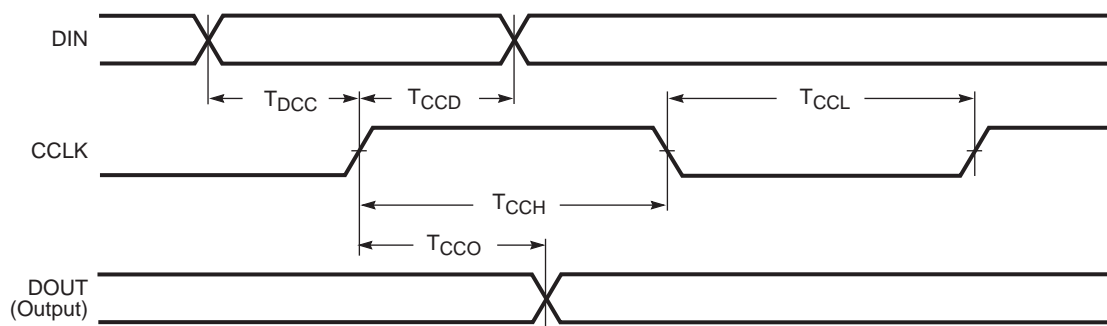
To reconfigure the device, the $\overline{PROGRAM}$ pin should be asserted to reset the configuration logic. Recycling power also resets the FPGA for configuration. See "Clearing Configuration Memory".

Start-up

The start-up sequence oversees the transition of the FPGA from the configuration state to full user operation. A match of CRC values, indicating a successful loading of the configuration data, initiates the sequence.

During start-up, the device performs four operations:

1. The assertion of DONE. The failure of DONE to go High may indicate the unsuccessful loading of configuration data.
2. The release of the Global Three State net. This activates I/Os to which signals are assigned. The remaining I/Os stay in a high-impedance state with internal weak pull-down resistors present.
3. Negates Global Set Reset (GSR). This allows all flip-flops to change state.
4. The assertion of Global Write Enable (GWE). This allows all RAMs and flip-flops to change state.

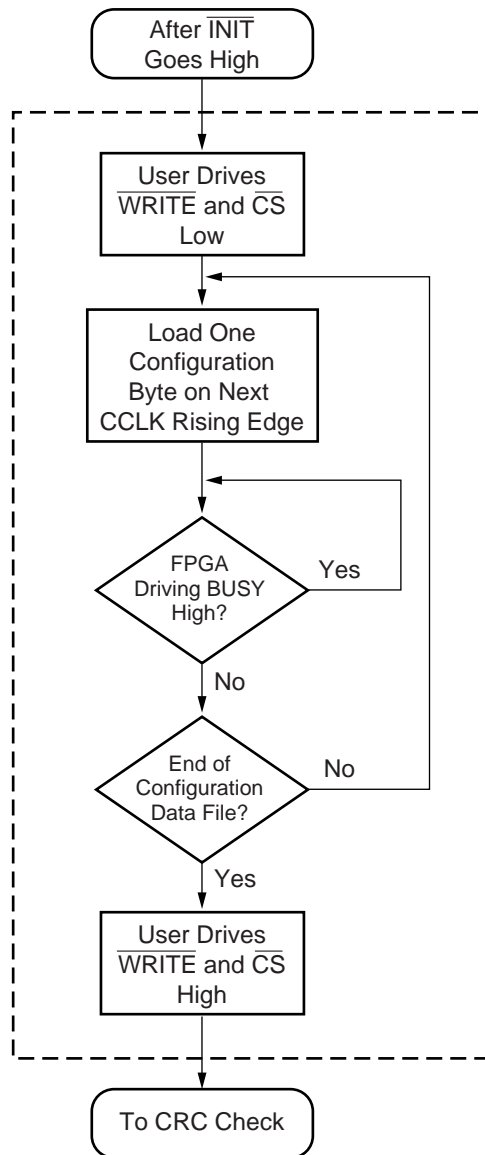


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| Symbol | | Description | | Units |
|-----------|------|-------------------|----|----------|
| T_{DCC} | CCLK | DIN setup | 5 | ns, min |
| T_{CCD} | | DIN hold | 0 | ns, min |
| T_{CCO} | | DOUT | 12 | ns, max |
| T_{CCH} | | High time | 5 | ns, min |
| T_{CCL} | | Low time | 5 | ns, min |
| F_{CC} | | Maximum frequency | 66 | MHz, max |

Figure 16: Slave Serial Mode Timing

If CCLK is slower than F_{CCNH} , the FPGA will never assert BUSY. In this case, the above handshake is unnecessary, and data can simply be entered into the FPGA every CCLK cycle.



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Figure 19: Loading Configuration Data for the Slave Parallel Mode

A configuration packet does not have to be written in one continuous stretch, rather it can be split into many write sequences. Each sequence would involve assertion of \overline{CS} .

In applications where multiple clock cycles may be required to access the configuration data before each byte can be loaded into the Slave Parallel interface, a new byte of data may not be ready for each consecutive CCLK edge. In such a case the \overline{CS} signal may be de-asserted until the next byte is valid on D0-D7. While \overline{CS} is High, the Slave Parallel

interface does not expect any data and ignores all CCLK transitions. However, to avoid aborting configuration, \overline{WRITE} must continue to be asserted while \overline{CS} is asserted.

Abort

To abort configuration during a write sequence, de-assert \overline{WRITE} while holding \overline{CS} Low. The abort operation is initiated at the rising edge of CCLK, as shown in Figure 21, page 26. The device will remain BUSY until the aborted operation is complete. After aborting configuration, data is assumed to be unaligned to word boundaries and the FPGA requires a new synchronization word prior to accepting any new packets.

Boundary-Scan Mode

In the boundary-scan mode, no nondedicated pins are required, configuration being done entirely through the IEEE 1149.1 Test Access Port.

Configuration through the TAP uses the special CFG_IN instruction. This instruction allows data input on TDI to be converted into data packets for the internal configuration bus.

The following steps are required to configure the FPGA through the boundary-scan port.

1. Load the CFG_IN instruction into the boundary-scan instruction register (IR)
2. Enter the Shift-DR (SDR) state
3. Shift a standard configuration bitstream into TDI
4. Return to Run-Test-Idle (RTI)
5. Load the JSTART instruction into IR
6. Enter the SDR state
7. Clock TCK through the sequence (the length is programmable)
8. Return to RTI

Configuration and readback via the TAP is always available. The boundary-scan mode simply locks out the other modes. The boundary-scan mode is selected by a <10x> on the mode pins (M0, M1, M2).

Readback

The configuration data stored in the Spartan-II FPGA configuration memory can be readback for verification. Along with the configuration data it is possible to readback the contents of all flip-flops/latches, LUT RAMs, and block RAMs. This capability is used for real-time debugging.

For more detailed information see [XAPP176](#), *Spartan-II FPGA Family Configuration and Readback*.

Using Block RAM Features

The Spartan-II FPGA family provides dedicated blocks of on-chip, true dual-read/write port synchronous RAM, with 4096 memory cells. Each port of the block RAM memory can be independently configured as a read/write port, a read port, a write port, and can be configured to a specific data width. The block RAM memory offers new capabilities allowing the FPGA designer to simplify designs.

Operating Modes

Block RAM memory supports two operating modes.

- Read Through
- Write Back

Read Through (One Clock Edge)

The read address is registered on the read port clock edge and data appears on the output after the RAM access time. Some memories may place the latch/register at the outputs depending on the desire to have a faster clock-to-out versus setup time. This is generally considered to be an inferior solution since it changes the read operation to an asynchronous function with the possibility of missing an address/control line transition during the generation of the read pulse clock.

Write Back (One Clock Edge)

The write address is registered on the write port clock edge and the data input is written to the memory and mirrored on the write port input.

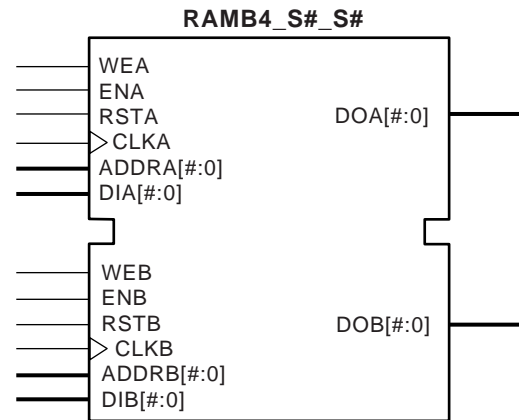
Block RAM Characteristics

1. All inputs are registered with the port clock and have a setup to clock timing specification.
2. All outputs have a read through or write back function depending on the state of the port WE pin. The outputs relative to the port clock are available after the clock-to-out timing specification.
3. The block RAM are true SRAM memories and do not have a combinatorial path from the address to the output. The LUT cells in the CLBs are still available with this function.
4. The ports are completely independent from each other (*i.e.*, clocking, control, address, read/write function, and data width) without arbitration.
5. A write operation requires only one clock edge.
6. A read operation requires only one clock edge.

The output ports are latched with a self timed circuit to guarantee a glitch free read. The state of the output port will not change until the port executes another read or write operation.

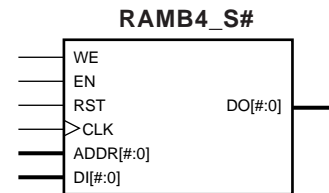
Library Primitives

Figure 31 and Figure 32 show the two generic library block RAM primitives. Table 11 describes all of the available primitives for synthesis and simulation.



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Figure 31: Dual-Port Block RAM Memory

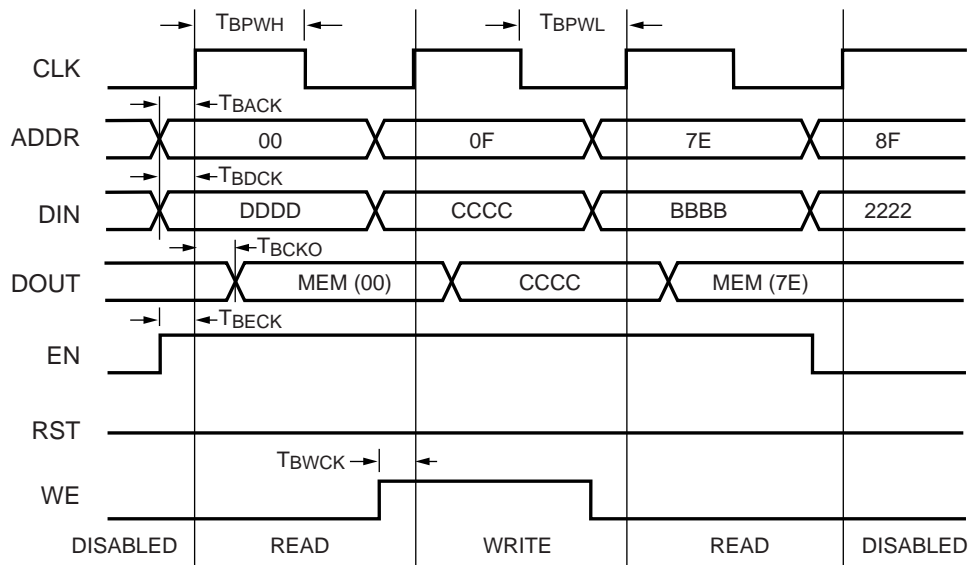


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Figure 32: Single-Port Block RAM Memory

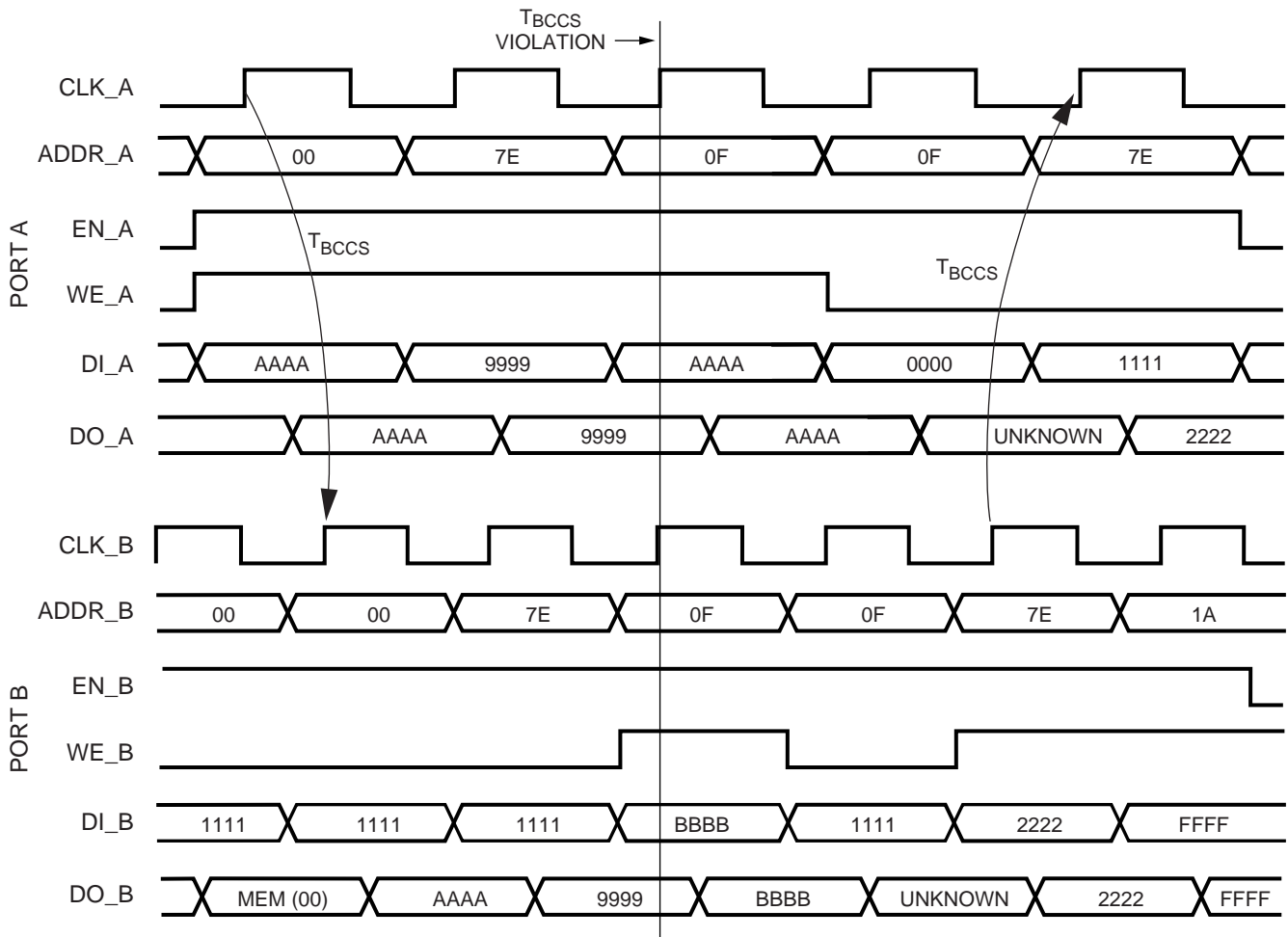
Table 11: Available Library Primitives

| Primitive | Port A Width | Port B Width |
|--------------|--------------|--------------|
| RAMB4_S1 | 1 | N/A |
| RAMB4_S1_S1 | | 1 |
| RAMB4_S1_S2 | | 2 |
| RAMB4_S1_S4 | | 4 |
| RAMB4_S1_S8 | | 8 |
| RAMB4_S1_S16 | | 16 |
| RAMB4_S2 | 2 | N/A |
| RAMB4_S2_S2 | | 2 |
| RAMB4_S2_S4 | | 4 |
| RAMB4_S2_S8 | | 8 |
| RAMB4_S2_S16 | | 16 |



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Figure 33: Timing Diagram for Single-Port Block RAM Memory



DS001_34_061200

Figure 34: Timing Diagram for a True Dual-Port Read/Write Block RAM Memory

LVTTL

LVTTL requires no termination. DC voltage specifications appears in [Table 32](#) for the LVTTL standard. See "[DC Specifications](#)" in Module 3 for the actual FPGA characteristics.

Table 32: LVTTL Voltage Specifications

| Parameter | Min | Typ | Max |
|---------------------------|------|-----|-----|
| V_{CCO} | 3.0 | 3.3 | 3.6 |
| V_{REF} | - | - | - |
| V_{TT} | - | - | - |
| V_{IH} | 2.0 | - | 5.5 |
| V_{IL} | -0.5 | - | 0.8 |
| V_{OH} | 2.4 | - | - |
| V_{OL} | - | - | 0.4 |
| I_{OH} at V_{OH} (mA) | -24 | - | - |
| I_{OL} at V_{OL} (mA) | 24 | - | - |

Notes:

1. V_{OL} and V_{OH} for lower drive currents sample tested.

LVC MOS2

LVC MOS2 requires no termination. DC voltage specifications appear in [Table 33](#) for the LVC MOS2 standard. See "[DC Specifications](#)" in Module 3 for the actual FPGA characteristics.

Table 33: LVC MOS2 Voltage Specifications

| Parameter | Min | Typ | Max |
|---------------------------|------|-----|-----|
| V_{CCO} | 2.3 | 2.5 | 2.7 |
| V_{REF} | - | - | - |
| V_{TT} | - | - | - |
| V_{IH} | 1.7 | - | 5.5 |
| V_{IL} | -0.5 | - | 0.7 |
| V_{OH} | 1.9 | - | - |
| V_{OL} | - | - | 0.4 |
| I_{OH} at V_{OH} (mA) | -12 | - | - |
| I_{OL} at V_{OL} (mA) | 12 | - | - |

AGP-2X

The specification for the AGP-2X standard does not document a recommended termination technique. DC voltage specifications appear in [Table 34](#) for the AGP-2X standard. See "[DC Specifications](#)" in Module 3 for the actual FPGA characteristics.

Table 34: AGP-2X Voltage Specifications

| Parameter | Min | Typ | Max |
|------------------------------------|--------|------|------|
| V_{CCO} | 3.0 | 3.3 | 3.6 |
| $V_{REF} = N \times V_{CCO}^{(1)}$ | 1.17 | 1.32 | 1.48 |
| V_{TT} | - | - | - |
| $V_{IH} \geq V_{REF} + 0.2$ | 1.37 | 1.52 | - |
| $V_{IL} \leq V_{REF} - 0.2$ | - | 1.12 | 1.28 |
| $V_{OH} \geq 0.9 \times V_{CCO}$ | 2.7 | 3.0 | - |
| $V_{OL} \leq 0.1 \times V_{CCO}$ | - | 0.33 | 0.36 |
| I_{OH} at V_{OH} (mA) | Note 2 | - | - |
| I_{OL} at V_{OL} (mA) | Note 2 | - | - |

Notes:

1. N must be greater than or equal to 0.39 and less than or equal to 0.41.
2. Tested according to the relevant specification.

For design examples and more information on using the I/O, see [XAPP179](#), *Using SelectIO Interfaces in Spartan-II and Spartan-IIe FPGAs*.

Definition of Terms

In this document, some specifications may be designated as Advance or Preliminary. These terms are defined as follows:

Advance: Initial estimates based on simulation and/or extrapolation from other speed grades, devices, or families. Values are subject to change. Use as estimates, not for production.

Preliminary: Based on preliminary characterization. Further changes are not expected.

Unmarked: Specifications not identified as either Advance or Preliminary are to be considered Final.

Except for pin-to-pin input and output parameters, the AC parameter delay specifications included in this document are derived from measuring internal test patterns. All limits are representative of worst-case supply voltage and junction temperature conditions. Typical numbers are based on measurements taken at a nominal V_{CCINT} level of 2.5V and a junction temperature of 25°C. The parameters included are common to popular designs and typical applications. **All specifications are subject to change without notice.**

DC Specifications

Absolute Maximum Ratings⁽¹⁾

| Symbol | Description | Min | Max | Units |
|-------------|---|------|-----------------|-------|
| V_{CCINT} | Supply voltage relative to GND ⁽²⁾ | -0.5 | 3.0 | V |
| V_{CCO} | Supply voltage relative to GND ⁽²⁾ | -0.5 | 4.0 | V |
| V_{REF} | Input reference voltage | -0.5 | 3.6 | V |
| V_{IN} | Input voltage relative to GND ⁽³⁾ | | | |
| | 5V tolerant I/O ⁽⁴⁾ | -0.5 | 5.5 | V |
| | No 5V tolerance ⁽⁵⁾ | -0.5 | $V_{CCO} + 0.5$ | V |
| V_{TS} | Voltage applied to 3-state output | | | |
| | 5V tolerant I/O ⁽⁴⁾ | -0.5 | 5.5 | V |
| | No 5V tolerance ⁽⁵⁾ | -0.5 | $V_{CCO} + 0.5$ | V |
| T_{STG} | Storage temperature (ambient) | -65 | +150 | °C |
| T_J | Junction temperature | - | +125 | °C |

Notes:

- Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those listed under Operating Conditions is not implied. Exposure to Absolute Maximum Ratings conditions for extended periods of time may affect device reliability.
- Power supplies may turn on in any order.
- V_{IN} should not exceed V_{CCO} by more than 3.6V over extended periods of time (e.g., longer than a day).
- Spartan®-II device I/Os are 5V Tolerant whenever the LVTTTL, LVC MOS2, or PCI33_5 signal standard has been selected. With 5V Tolerant I/Os selected, the Maximum DC overshoot must be limited to either +5.5V or 10 mA, and undershoot must be limited to either -0.5V or 10 mA, whichever is easier to achieve. The Maximum AC conditions are as follows: The device pins may undershoot to -2.0V or overshoot to +7.0V, provided this over/undershoot lasts no more than 11 ns with a forcing current no greater than 100 mA.
- Without 5V Tolerant I/Os selected, the Maximum DC overshoot must be limited to either $V_{CCO} + 0.5V$ or 10 mA, and undershoot must be limited to -0.5V or 10 mA, whichever is easier to achieve. The Maximum AC conditions are as follows: The device pins may undershoot to -2.0V or overshoot to $V_{CCO} + 2.0V$, provided this over/undershoot lasts no more than 11 ns with a forcing current no greater than 100 mA.
- For soldering guidelines, see the [Packaging Information](#) on the Xilinx® web site.

| Input/Output Standard | V_{IL} | | V_{IH} | | V_{OL} | V_{OH} | I_{OL} | I_{OH} |
|-----------------------|----------|-----------------|-----------------|--------|-----------------|-----------------|----------|----------|
| | V, Min | V, Max | V, Min | V, Max | V, Max | V, Min | mA | mA |
| CTT | -0.5 | $V_{REF} - 0.2$ | $V_{REF} + 0.2$ | 3.6 | $V_{REF} - 0.4$ | $V_{REF} + 0.4$ | 8 | -8 |
| AGP | -0.5 | $V_{REF} - 0.2$ | $V_{REF} + 0.2$ | 3.6 | 10% V_{CCO} | 90% V_{CCO} | Note (2) | Note (2) |

Notes:

1. V_{OL} and V_{OH} for lower drive currents are sample tested.
2. Tested according to the relevant specifications.

Switching Characteristics

All devices are 100% functionally tested. Internal timing parameters are derived from measuring internal test patterns. Listed below are representative values. For more specific, more precise, and worst-case guaranteed data, use the values reported by the static timing analyzer (TRCE

in the Xilinx Development System) and back-annotated to the simulation netlist. All timing parameters assume worst-case operating conditions (supply voltage and junction temperature). Values apply to all Spartan-II devices unless otherwise noted.

Global Clock Input to Output Delay for LVTTL, with DLL (Pin-to-Pin)⁽¹⁾

| Symbol | Description | Device | Speed Grade | | | Units |
|----------------|--|--------|-------------|-----|-----|-------|
| | | | All | -6 | -5 | |
| | | | Min | Max | Max | |
| $T_{ICKOFDLL}$ | Global clock input to output delay using output flip-flop for LVTTL, 12 mA, fast slew rate, <i>with</i> DLL. | All | | 2.9 | 3.3 | ns |

Notes:

1. Listed above are representative values where one global clock input drives one vertical clock line in each accessible column, and where all accessible IOB and CLB flip-flops are clocked by the global clock net.
2. Output timing is measured at 1.4V with 35 pF external capacitive load for LVTTL. The 35 pF load does not apply to the Min values. For other I/O standards and different loads, see the tables ["Constants for Calculating TIOOP"](#) and ["Delay Measurement Methodology,"](#) page 60.
3. DLL output jitter is already included in the timing calculation.
4. For data *output* with different standards, adjust delays with the values shown in ["IOB Output Delay Adjustments for Different Standards,"](#) page 59. For a global clock input with standards other than LVTTL, adjust delays with values from the ["I/O Standard Global Clock Input Adjustments,"](#) page 61.

Global Clock Input to Output Delay for LVTTL, without DLL (Pin-to-Pin)⁽¹⁾

| Symbol | Description | Device | Speed Grade | | | Units |
|-------------|---|---------|-------------|-----|-----|-------|
| | | | All | -6 | -5 | |
| | | | Min | Max | Max | |
| T_{ICKOF} | Global clock input to output delay using output flip-flop for LVTTL, 12 mA, fast slew rate, <i>without</i> DLL. | XC2S15 | | 4.5 | 5.4 | ns |
| | | XC2S30 | | 4.5 | 5.4 | ns |
| | | XC2S50 | | 4.5 | 5.4 | ns |
| | | XC2S100 | | 4.6 | 5.5 | ns |
| | | XC2S150 | | 4.6 | 5.5 | ns |
| | | XC2S200 | | 4.7 | 5.6 | ns |

Notes:

1. Listed above are representative values where one global clock input drives one vertical clock line in each accessible column, and where all accessible IOB and CLB flip-flops are clocked by the global clock net.
2. Output timing is measured at 1.4V with 35 pF external capacitive load for LVTTL. The 35 pF load does not apply to the Min values. For other I/O standards and different loads, see the tables ["Constants for Calculating TIOOP"](#) and ["Delay Measurement Methodology,"](#) page 60.
3. For data *output* with different standards, adjust delays with the values shown in ["IOB Output Delay Adjustments for Different Standards,"](#) page 59. For a global clock input with standards other than LVTTL, adjust delays with values from the ["I/O Standard Global Clock Input Adjustments,"](#) page 61.

IOB Input Switching Characteristics⁽¹⁾

Input delays associated with the pad are specified for LVTTTL levels. For other standards, adjust the delays with the values shown in "IOB Input Delay Adjustments for Different Standards," page 57.

| Symbol | Description | Device | Speed Grade | | | | Units |
|---|--|---------|-------------|-----|------------|------|-------|
| | | | -6 | | -5 | | |
| | | | Min | Max | Min | Max | |
| Propagation Delays | | | | | | | |
| T _{IOPI} | Pad to I output, no delay | All | - | 0.8 | - | 1.0 | ns |
| T _{IOPID} | Pad to I output, with delay | All | - | 1.5 | - | 1.8 | ns |
| T _{IOPLI} | Pad to output IQ via transparent latch, no delay | All | - | 1.7 | - | 2.0 | ns |
| T _{IOPLID} | Pad to output IQ via transparent latch, with delay | XC2S15 | - | 3.8 | - | 4.5 | ns |
| | | XC2S30 | - | 3.8 | - | 4.5 | ns |
| | | XC2S50 | - | 3.8 | - | 4.5 | ns |
| | | XC2S100 | - | 3.8 | - | 4.5 | ns |
| | | XC2S150 | - | 4.0 | - | 4.7 | ns |
| | | XC2S200 | - | 4.0 | - | 4.7 | ns |
| Sequential Delays | | | | | | | |
| T _{IOCKIQ} | Clock CLK to output IQ | All | - | 0.7 | - | 0.8 | ns |
| Setup/Hold Times with Respect to Clock CLK ⁽²⁾ | | | | | | | |
| T _{IOPICK} / T _{IOICKP} | Pad, no delay | All | 1.7 / 0 | - | 1.9 / 0 | - | ns |
| T _{IOPICKD} / T _{IOICKPD} | Pad, with delay ⁽¹⁾ | XC2S15 | 3.8 / 0 | - | 4.4 / 0 | - | ns |
| | | XC2S30 | 3.8 / 0 | - | 4.4 / 0 | - | ns |
| | | XC2S50 | 3.8 / 0 | - | 4.4 / 0 | - | ns |
| | | XC2S100 | 3.8 / 0 | - | 4.4 / 0 | - | ns |
| | | XC2S150 | 3.9 / 0 | - | 4.6 / 0 | - | ns |
| | | XC2S200 | 3.9 / 0 | - | 4.6 / 0 | - | ns |
| T _{IOICECK} / T _{IOICKICE} | ICE input | All | 0.9 / 0.01 | - | 0.9 / 0.01 | - | ns |
| Set/Reset Delays | | | | | | | |
| T _{IOSRCKI} | SR input (IFF, synchronous) | All | - | 1.1 | - | 1.2 | ns |
| T _{IOSRIQ} | SR input to IQ (asynchronous) | All | - | 1.5 | - | 1.7 | ns |
| T _{GSRQ} | GSR to output IQ | All | - | 9.9 | - | 11.7 | ns |

Notes:

- Input timing for LVTTTL is measured at 1.4V. For other I/O standards, see the table "Delay Measurement Methodology," page 60.
- A zero hold time listing indicates no hold time or a negative hold time.

IOB Output Delay Adjustments for Different Standards⁽¹⁾

Output delays terminating at a pad are specified for LVTTL with 12 mA drive and fast slew rate. For other standards, adjust the delays by the values shown. A delay adjusted in this way constitutes a worst-case limit.

| Symbol | Description | Standard | Speed Grade | | Units |
|--------------------------------|---|-------------------|-------------|------|-------|
| | | | -6 | -5 | |
| Output Delay Adjustments (Adj) | | | | | |
| T _{OLVTTTL_S2} | Standard-specific adjustments for output delays terminating at pads (based on standard capacitive load, C _{SL}) | LVTTL, Slow, 2 mA | 14.2 | 16.9 | ns |
| T _{OLVTTTL_S4} | | 4 mA | 7.2 | 8.6 | ns |
| T _{OLVTTTL_S6} | | 6 mA | 4.7 | 5.5 | ns |
| T _{OLVTTTL_S8} | | 8 mA | 2.9 | 3.5 | ns |
| T _{OLVTTTL_S12} | | 12 mA | 1.9 | 2.2 | ns |
| T _{OLVTTTL_S16} | | 16 mA | 1.7 | 2.0 | ns |
| T _{OLVTTTL_S24} | | 24 mA | 1.3 | 1.5 | ns |
| T _{OLVTTTL_F2} | | LVTTL, Fast, 2 mA | 12.6 | 15.0 | ns |
| T _{OLVTTTL_F4} | | 4 mA | 5.1 | 6.1 | ns |
| T _{OLVTTTL_F6} | | 6 mA | 3.0 | 3.6 | ns |
| T _{OLVTTTL_F8} | | 8 mA | 1.0 | 1.2 | ns |
| T _{OLVTTTL_F12} | | 12 mA | 0 | 0 | ns |
| T _{OLVTTTL_F16} | | 16 mA | −0.1 | −0.1 | ns |
| T _{OLVTTTL_F24} | | 24 mA | −0.1 | −0.2 | ns |
| T _{OLVCMOS2} | | LVC MOS2 | 0.2 | 0.2 | ns |
| T _{OPCI33_3} | | PCI, 33 MHz, 3.3V | 2.4 | 2.9 | ns |
| T _{OPCI33_5} | | PCI, 33 MHz, 5.0V | 2.9 | 3.5 | ns |
| T _{OPCI66_3} | | PCI, 66 MHz, 3.3V | −0.3 | −0.4 | ns |
| T _{OGTL} | | GTL | 0.6 | 0.7 | ns |
| T _{OGTLP} | | GTL+ | 0.9 | 1.1 | ns |
| T _{OHSTL_I} | | HSTL I | −0.4 | −0.5 | ns |
| T _{OHSTL_III} | | HSTL III | −0.8 | −1.0 | ns |
| T _{OHSTL_IV} | | HSTL IV | −0.9 | −1.1 | ns |
| T _{OSSTL2_I} | | SSTL2 I | −0.4 | −0.5 | ns |
| T _{OSSTL2_II} | SSTL2 II | −0.8 | −1.0 | ns | |
| T _{OSSTL3_I} | SSTL3 I | −0.4 | −0.5 | ns | |
| T _{OSSTL3_II} | SSTL3 II | −0.9 | −1.1 | ns | |
| T _{OCTT} | CTT | −0.5 | −0.6 | ns | |
| T _{OAGP} | AGP | −0.8 | −1.0 | ns | |

Notes:

- Output timing is measured at 1.4V with 35 pF external capacitive load for LVTTL. For other I/O standards and different loads, see the tables "Constants for Calculating TIOOP" and "Delay Measurement Methodology," page 60.

CLB Arithmetic Switching Characteristics

Setup times not listed explicitly can be approximated by decreasing the combinatorial delays by the setup time adjustment listed. Precise values are provided by the timing analyzer.

| Symbol | Description | Speed Grade | | | | Units |
|---|--|-------------|-----|---------|-----|-------|
| | | -6 | | -5 | | |
| | | Min | Max | Min | Max | |
| Combinatorial Delays | | | | | | |
| T _{OPX} | F operand inputs to X via XOR | - | 0.8 | - | 0.9 | ns |
| T _{OPXB} | F operand input to XB output | - | 1.3 | - | 1.5 | ns |
| T _{OPY} | F operand input to Y via XOR | - | 1.7 | - | 2.0 | ns |
| T _{OPYB} | F operand input to YB output | - | 1.7 | - | 2.0 | ns |
| T _{OPCYF} | F operand input to COUT output | - | 1.3 | - | 1.5 | ns |
| T _{OPGY} | G operand inputs to Y via XOR | - | 0.9 | - | 1.1 | ns |
| T _{OPGYB} | G operand input to YB output | - | 1.6 | - | 2.0 | ns |
| T _{OPCYG} | G operand input to COUT output | - | 1.2 | - | 1.4 | ns |
| T _{BXCY} | BX initialization input to COUT | - | 0.9 | - | 1.0 | ns |
| T _{CINX} | CIN input to X output via XOR | - | 0.4 | - | 0.5 | ns |
| T _{CINXB} | CIN input to XB | - | 0.1 | - | 0.1 | ns |
| T _{CINY} | CIN input to Y via XOR | - | 0.5 | - | 0.6 | ns |
| T _{CINYB} | CIN input to YB | - | 0.6 | - | 0.7 | ns |
| T _{BYP} | CIN input to COUT output | - | 0.1 | - | 0.1 | ns |
| Multiplier Operation | | | | | | |
| T _{FANDXB} | F1/2 operand inputs to XB output via AND | - | 0.5 | - | 0.5 | ns |
| T _{FANDYB} | F1/2 operand inputs to YB output via AND | - | 0.9 | - | 1.1 | ns |
| T _{FANDCY} | F1/2 operand inputs to COUT output via AND | - | 0.5 | - | 0.6 | ns |
| T _{GANDYB} | G1/2 operand inputs to YB output via AND | - | 0.6 | - | 0.7 | ns |
| T _{GANDCY} | G1/2 operand inputs to COUT output via AND | - | 0.2 | - | 0.2 | ns |
| Setup/Hold Times with Respect to Clock CLK ⁽¹⁾ | | | | | | |
| T _{CCKX} / T _{CKCX} | CIN input to FFX | 1.1 / 0 | - | 1.2 / 0 | - | ns |
| T _{CCKY} / T _{CKCY} | CIN input to FFY | 1.2 / 0 | - | 1.3 / 0 | - | ns |

Notes:

1. A zero hold time listing indicates no hold time or a negative hold time.

Table 36: Spartan-II Family Package Options

| Package | Leads | Type | Maximum I/O | Lead Pitch (mm) | Footprint Area (mm) | Height (mm) | Mass ⁽¹⁾ (g) |
|----------------|-------|------------------------------------|-------------|-----------------|---------------------|-------------|-------------------------|
| VQ100 / VQG100 | 100 | Very Thin Quad Flat Pack (VQFP) | 60 | 0.5 | 16 x 16 | 1.20 | 0.6 |
| TQ144 / TQG144 | 144 | Thin Quad Flat Pack (TQFP) | 92 | 0.5 | 22 x 22 | 1.60 | 1.4 |
| CS144 / CSG144 | 144 | Chip Scale Ball Grid Array (CSBGA) | 92 | 0.8 | 12 x 12 | 1.20 | 0.3 |
| PQ208 / PQG208 | 208 | Plastic Quad Flat Pack (PQFP) | 140 | 0.5 | 30.6 x 30.6 | 3.70 | 5.3 |
| FG256 / FGG256 | 256 | Fine-pitch Ball Grid Array (FBGA) | 176 | 1.0 | 17 x 17 | 2.00 | 0.9 |
| FG456 / FGG456 | 456 | Fine-pitch Ball Grid Array (FBGA) | 284 | 1.0 | 23 x 23 | 2.60 | 2.2 |

Notes:

- Package mass is $\pm 10\%$.

Note: Some early versions of Spartan-II devices, including the XC2S15 and XC2S30 ES devices and the XC2S150 with date code 0045 or earlier, included a power-down pin. For more information, see [Answer Record 10500](#).

VCCO Banks

Some of the I/O standards require specific V_{CCO} voltages. These voltages are externally connected to device pins that serve groups of IOBs, called banks. Eight I/O banks result from separating each edge of the FPGA into two banks (see [Figure 3](#) in Module 2). Each bank has multiple V_{CCO} pins which must be connected to the same voltage. In the smaller packages, the V_{CCO} pins are connected between banks, effectively reducing the number of independent banks available (see [Table 37](#)). These interconnected banks are shown in the Pinout Tables with V_{CCO} pads for multiple banks connected to the same pin.

Table 37: Independent VCCO Banks Available

| Package | VQ100 PQ208 | CS144 TQ144 | FG256 FG456 |
|-------------------|----------------|----------------|----------------|
| Independent Banks | 1 | 4 | 8 |

Package Overview

[Table 36](#) shows the six low-cost, space-saving production package styles for the Spartan-II family.

Each package style is available in an environmentally friendly lead-free (Pb-free) option. The Pb-free packages include an extra 'G' in the package style name. For example, the standard "CS144" package becomes "CSG144" when ordered as the Pb-free option. Leaded (non-Pb-free) packages may be available for selected devices, with the same pin-out and without the "G" in the ordering code; contact Xilinx sales for more information. The mechanical dimensions of the standard and Pb-free packages are similar, as shown in the mechanical drawings provided in [Table 38](#).

For additional package information, see [UG112: Device Package User Guide](#).

Mechanical Drawings

Detailed mechanical drawings for each package type are available from the Xilinx web site at the specified location in [Table 38](#).

Material Declaration Data Sheets (MDDS) are also available on the [Xilinx web site](#) for each package.

Table 38: Xilinx Package Documentation

| Package | Drawing | MDDS |
|---------|---------------------------------|------------------------------|
| VQ100 | Package Drawing | PK173_VQ100 |
| VQG100 | | PK130_VQG100 |
| TQ144 | Package Drawing | PK169_TQ144 |
| TQG144 | | PK126_TQG144 |
| CS144 | Package Drawing | PK149_CS144 |
| CSG144 | | PK103_CSG144 |
| PQ208 | Package Drawing | PK166_PQ208 |
| PQG208 | | PK123_PQG208 |
| FG256 | Package Drawing | PK151_FG256 |
| FGG256 | | PK105_FGG256 |
| FG456 | Package Drawing | PK154_FG456 |
| FGG456 | | PK109_FGG456 |

Pinout Tables

The following device-specific pinout tables include all packages available for each Spartan®-II device. They follow the pad locations around the die, and include Boundary Scan register locations.

XC2S15 Device Pinouts

| XC2S15 Pad Name | | VQ100 | TQ144 | CS144 | Bndry Scan |
|--------------------------|------|-------|-------|-------|------------|
| Function | Bank | | | | |
| GND | - | P1 | P143 | A1 | - |
| TMS | - | P2 | P142 | B1 | - |
| I/O | 7 | P3 | P141 | C2 | 77 |
| I/O | 7 | - | P140 | C1 | 80 |
| I/O, V _{REF} | 7 | P4 | P139 | D4 | 83 |
| I/O | 7 | P5 | P137 | D2 | 86 |
| I/O | 7 | P6 | P136 | D1 | 89 |
| GND | - | - | P135 | E4 | - |
| I/O | 7 | P7 | P134 | E3 | 92 |
| I/O | 7 | - | P133 | E2 | 95 |
| I/O, V _{REF} | 7 | P8 | P132 | E1 | 98 |
| I/O | 7 | P9 | P131 | F4 | 101 |
| I/O | 7 | - | P130 | F3 | 104 |
| I/O, IRDY ⁽¹⁾ | 7 | P10 | P129 | F2 | 107 |
| GND | - | P11 | P128 | F1 | - |
| V _{CCO} | 7 | P12 | P127 | G2 | - |
| V _{CCO} | 6 | P12 | P127 | G2 | - |
| I/O, TRDY ⁽¹⁾ | 6 | P13 | P126 | G1 | 110 |
| V _{CCINT} | - | P14 | P125 | G3 | - |
| I/O | 6 | - | P124 | G4 | 113 |
| I/O | 6 | P15 | P123 | H1 | 116 |
| I/O, V _{REF} | 6 | P16 | P122 | H2 | 119 |
| I/O | 6 | - | P121 | H3 | 122 |
| I/O | 6 | P17 | P120 | H4 | 125 |
| GND | - | - | P119 | J1 | - |
| I/O | 6 | P18 | P118 | J2 | 128 |
| I/O | 6 | P19 | P117 | J3 | 131 |
| I/O, V _{REF} | 6 | P20 | P115 | K1 | 134 |
| I/O | 6 | - | P114 | K2 | 137 |
| I/O | 6 | P21 | P113 | K3 | 140 |
| I/O | 6 | P22 | P112 | L1 | 143 |
| M1 | - | P23 | P111 | L2 | 146 |
| GND | - | P24 | P110 | L3 | - |
| M0 | - | P25 | P109 | M1 | 147 |
| V _{CCO} | 6 | P26 | P108 | M2 | - |
| V _{CCO} | 5 | P26 | P107 | N1 | - |

XC2S15 Device Pinouts (Continued)

| XC2S15 Pad Name | | VQ100 | TQ144 | CS144 | Bndry Scan |
|-----------------------|------|-------|-------|-------|------------|
| Function | Bank | | | | |
| M2 | - | P27 | P106 | N2 | 148 |
| I/O | 5 | - | P103 | K4 | 155 |
| I/O, V _{REF} | 5 | P30 | P102 | L4 | 158 |
| I/O | 5 | P31 | P100 | N4 | 161 |
| I/O | 5 | P32 | P99 | K5 | 164 |
| GND | - | - | P98 | L5 | - |
| V _{CCINT} | - | P33 | P97 | M5 | - |
| I/O | 5 | - | P96 | N5 | 167 |
| I/O | 5 | - | P95 | K6 | 170 |
| I/O, V _{REF} | 5 | P34 | P94 | L6 | 173 |
| I/O | 5 | - | P93 | M6 | 176 |
| V _{CCINT} | - | P35 | P92 | N6 | - |
| I, GCK1 | 5 | P36 | P91 | M7 | 185 |
| V _{CCO} | 5 | P37 | P90 | N7 | - |
| V _{CCO} | 4 | P37 | P90 | N7 | - |
| GND | - | P38 | P89 | L7 | - |
| I, GCK0 | 4 | P39 | P88 | K7 | 186 |
| I/O | 4 | P40 | P87 | N8 | 190 |
| I/O | 4 | - | P86 | M8 | 193 |
| I/O, V _{REF} | 4 | P41 | P85 | L8 | 196 |
| I/O | 4 | - | P84 | K8 | 199 |
| I/O | 4 | - | P83 | N9 | 202 |
| V _{CCINT} | - | P42 | P82 | M9 | - |
| GND | - | - | P81 | L9 | - |
| I/O | 4 | P43 | P80 | K9 | 205 |
| I/O | 4 | P44 | P79 | N10 | 208 |
| I/O, V _{REF} | 4 | P45 | P77 | L10 | 211 |
| I/O | 4 | - | P76 | N11 | 214 |
| I/O | 4 | P46 | P75 | M11 | 217 |
| I/O | 4 | P47 | P74 | L11 | 220 |
| GND | - | P48 | P73 | N12 | - |
| DONE | 3 | P49 | P72 | M12 | 223 |
| V _{CCO} | 4 | P50 | P71 | N13 | - |
| V _{CCO} | 3 | P50 | P70 | M13 | - |
| PROGRAM | - | P51 | P69 | L12 | 226 |
| I/O (INIT) | 3 | P52 | P68 | L13 | 227 |
| I/O (D7) | 3 | P53 | P67 | K10 | 230 |
| I/O | 3 | - | P66 | K11 | 233 |
| I/O, V _{REF} | 3 | P54 | P65 | K12 | 236 |
| I/O | 3 | P55 | P63 | J10 | 239 |
| I/O (D6) | 3 | P56 | P62 | J11 | 242 |

Additional XC2S50 Package Pins (Continued)

PQ208

| Not Connected Pins | | | | | |
|--------------------|-----|---|---|---|---|
| P55 | P56 | - | - | - | - |

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FG256

| V _{CCINT} Pins | | | | | |
|------------------------------|-----|-----|-----|----|-----|
| C3 | C14 | D4 | D13 | E5 | E12 |
| M5 | M12 | N4 | N13 | P3 | P14 |
| V _{CCO} Bank 0 Pins | | | | | |
| E8 | F8 | - | - | - | - |
| V _{CCO} Bank 1 Pins | | | | | |
| E9 | F9 | - | - | - | - |
| V _{CCO} Bank 2 Pins | | | | | |
| H11 | H12 | - | - | - | - |
| V _{CCO} Bank 3 Pins | | | | | |
| J11 | J12 | - | - | - | - |
| V _{CCO} Bank 4 Pins | | | | | |
| L9 | M9 | - | - | - | - |
| V _{CCO} Bank 5 Pins | | | | | |
| L8 | M8 | - | - | - | - |
| V _{CCO} Bank 6 Pins | | | | | |
| J5 | J6 | - | - | - | - |
| V _{CCO} Bank 7 Pins | | | | | |
| H5 | H6 | - | - | - | - |
| GND Pins | | | | | |
| A1 | A16 | B2 | B15 | F6 | F7 |
| F10 | F11 | G6 | G7 | G8 | G9 |
| G10 | G11 | H7 | H8 | H9 | H10 |
| J7 | J8 | J9 | J10 | K6 | K7 |
| K8 | K9 | K10 | K11 | L6 | L7 |
| L10 | L11 | R2 | R15 | T1 | T16 |
| Not Connected Pins | | | | | |
| P4 | R4 | - | - | - | - |

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XC2S100 Device Pinouts

| XC2S100 Pad Name | | | | | | |
|-----------------------|------|-------|-------|--------------------------|--------------------------|------------|
| Function | Bank | TQ144 | PQ208 | FG256 | FG456 | Bndry Scan |
| GND | - | P143 | P1 | GND* | GND* | - |
| TMS | - | P142 | P2 | D3 | D3 | - |
| I/O | 7 | P141 | P3 | C2 | B1 | 185 |
| I/O | 7 | - | - | A2 | F5 | 191 |
| I/O | 7 | P140 | P4 | B1 | D2 | 194 |
| I/O | 7 | - | - | - | E3 | 197 |
| I/O | 7 | - | - | E3 | G5 | 200 |
| I/O | 7 | - | P5 | D2 | F3 | 203 |
| GND | - | - | - | GND* | GND* | - |
| V _{CCO} | 7 | - | - | V _{CCO} Bank 7* | V _{CCO} Bank 7* | - |
| I/O, V _{REF} | 7 | P139 | P6 | C1 | E2 | 206 |

XC2S100 Device Pinouts (Continued)

| XC2S100 Pad Name | | | | | | |
|--------------------------|------|-------|-------|--------------------------|--------------------------|------------|
| Function | Bank | TQ144 | PQ208 | FG256 | FG456 | Bndry Scan |
| I/O | 7 | - | P7 | F3 | E1 | 209 |
| I/O | 7 | - | - | E2 | H5 | 215 |
| I/O | 7 | P138 | P8 | E4 | F2 | 218 |
| I/O | 7 | - | - | - | F1 | 221 |
| I/O, V _{REF} | 7 | P137 | P9 | D1 | H4 | 224 |
| I/O | 7 | P136 | P10 | E1 | G1 | 227 |
| GND | - | P135 | P11 | GND* | GND* | - |
| V _{CCO} | 7 | - | P12 | V _{CCO} Bank 7* | V _{CCO} Bank 7* | - |
| V _{CCINT} | - | - | P13 | V _{CCINT} * | V _{CCINT} * | - |
| I/O | 7 | P134 | P14 | F2 | H3 | 230 |
| I/O | 7 | P133 | P15 | G3 | H2 | 233 |
| I/O | 7 | - | - | F1 | J5 | 236 |
| I/O | 7 | - | P16 | F4 | J2 | 239 |
| I/O | 7 | - | P17 | F5 | K5 | 245 |
| I/O | 7 | - | P18 | G2 | K1 | 248 |
| GND | - | - | P19 | GND* | GND* | - |
| I/O, V _{REF} | 7 | P132 | P20 | H3 | K3 | 251 |
| I/O | 7 | P131 | P21 | G4 | K4 | 254 |
| I/O | 7 | - | - | H2 | L6 | 257 |
| I/O | 7 | P130 | P22 | G5 | L1 | 260 |
| I/O | 7 | - | P23 | H4 | L4 | 266 |
| I/O, IRDY ⁽¹⁾ | 7 | P129 | P24 | G1 | L3 | 269 |
| GND | - | P128 | P25 | GND* | GND* | - |
| V _{CCO} | 7 | P127 | P26 | V _{CCO} Bank 7* | V _{CCO} Bank 7* | - |
| V _{CCO} | 6 | P127 | P26 | V _{CCO} Bank 6* | V _{CCO} Bank 6* | - |
| I/O, TRDY ⁽¹⁾ | 6 | P126 | P27 | J2 | M1 | 272 |
| V _{CCINT} | - | P125 | P28 | V _{CCINT} * | V _{CCINT} * | - |
| I/O | 6 | P124 | P29 | H1 | M3 | 281 |
| I/O | 6 | - | - | J4 | M4 | 284 |
| I/O | 6 | P123 | P30 | J1 | M5 | 287 |
| I/O, V _{REF} | 6 | P122 | P31 | J3 | N2 | 290 |
| GND | - | - | P32 | GND* | GND* | - |
| I/O | 6 | - | P33 | K5 | N3 | 293 |
| I/O | 6 | - | P34 | K2 | N4 | 296 |
| I/O | 6 | - | P35 | K1 | P2 | 302 |
| I/O | 6 | - | - | K3 | P4 | 305 |
| I/O | 6 | P121 | P36 | L1 | P3 | 308 |
| I/O | 6 | P120 | P37 | L2 | R2 | 311 |

XC2S100 Device Pinouts (Continued)

| XC2S100 Pad Name | | TQ144 | PQ208 | FG256 | FG456 | Bndry Scan |
|-----------------------|------|-------|-------|-----------------------------|-----------------------------|------------|
| Function | Bank | | | | | |
| V _{CCINT} | - | - | P38 | V _{CCINT} * | V _{CCINT} * | - |
| V _{CCO} | 6 | - | P39 | V _{CCO} Bank 6* | V _{CCO} Bank 6* | - |
| GND | - | P119 | P40 | GND* | GND* | - |
| I/O | 6 | P118 | P41 | K4 | T1 | 314 |
| I/O, V _{REF} | 6 | P117 | P42 | M1 | R4 | 317 |
| I/O | 6 | - | - | - | T2 | 320 |
| I/O | 6 | P116 | P43 | L4 | U1 | 323 |
| I/O | 6 | - | - | M2 | R5 | 326 |
| I/O | 6 | - | P44 | L3 | U2 | 332 |
| I/O, V _{REF} | 6 | P115 | P45 | N1 | T3 | 335 |
| V _{CCO} | 6 | - | - | V _{CCO} Bank 6* | V _{CCO} Bank 6* | - |
| GND | - | - | - | GND* | GND* | - |
| I/O | 6 | - | P46 | P1 | T4 | 338 |
| I/O | 6 | - | - | L5 | W1 | 341 |
| I/O | 6 | - | - | - | U4 | 344 |
| I/O | 6 | P114 | P47 | N2 | Y1 | 347 |
| I/O | 6 | - | - | M4 | W2 | 350 |
| I/O | 6 | P113 | P48 | R1 | Y2 | 356 |
| I/O | 6 | P112 | P49 | M3 | W3 | 359 |
| M1 | - | P111 | P50 | P2 | U5 | 362 |
| GND | - | P110 | P51 | GND* | GND* | - |
| M0 | - | P109 | P52 | N3 | AB2 | 363 |
| V _{CCO} | 6 | P108 | P53 | V _{CCO} Bank 6* | V _{CCO} Bank 6* | - |
| V _{CCO} | 5 | P107 | P53 | V _{CCO} Bank 5* | V _{CCO} Bank 5* | - |
| M2 | - | P106 | P54 | R3 | Y4 | 364 |
| I/O | 5 | - | - | N5 | V7 | 374 |
| I/O | 5 | P103 | P57 | T2 | Y6 | 377 |
| I/O | 5 | - | - | - | AA4 | 380 |
| I/O | 5 | - | - | P5 | W6 | 383 |
| I/O | 5 | - | P58 | T3 | Y7 | 386 |
| GND | - | - | - | GND* | GND* | - |
| V _{CCO} | 5 | - | - | V _{CCO} Bank 5* | V _{CCO} Bank 5* | - |
| I/O, V _{REF} | 5 | P102 | P59 | T4 | AA5 | 389 |
| I/O | 5 | - | P60 | M6 | AB5 | 392 |
| I/O | 5 | - | - | T5 | AB6 | 398 |
| I/O | 5 | P101 | P61 | N6 | AA7 | 401 |
| I/O | 5 | - | - | - | W7 | 404 |

XC2S100 Device Pinouts (Continued)

| XC2S100 Pad Name | | TQ144 | PQ208 | FG256 | FG456 | Bndry Scan |
|-----------------------|------|-------|-------|-----------------------------|-----------------------------|------------|
| Function | Bank | | | | | |
| I/O, V _{REF} | 5 | P100 | P62 | R5 | W8 | 407 |
| I/O | 5 | P99 | P63 | P6 | Y8 | 410 |
| GND | - | P98 | P64 | GND* | GND* | - |
| V _{CCO} | 5 | - | P65 | V _{CCO} Bank 5* | V _{CCO} Bank 5* | - |
| V _{CCINT} | - | P97 | P66 | V _{CCINT} * | V _{CCINT} * | - |
| I/O | 5 | P96 | P67 | R6 | AA8 | 413 |
| I/O | 5 | P95 | P68 | M7 | V9 | 416 |
| I/O | 5 | - | - | - | AB9 | 419 |
| I/O | 5 | - | P69 | N7 | Y9 | 422 |
| I/O | 5 | - | P70 | T6 | W10 | 428 |
| I/O | 5 | - | P71 | P7 | AB10 | 431 |
| GND | - | - | P72 | GND* | GND* | - |
| I/O, V _{REF} | 5 | P94 | P73 | P8 | Y10 | 434 |
| I/O | 5 | - | P74 | R7 | V11 | 437 |
| I/O | 5 | - | - | T7 | W11 | 440 |
| I/O | 5 | P93 | P75 | T8 | AB11 | 443 |
| V _{CCINT} | - | P92 | P76 | V _{CCINT} * | V _{CCINT} * | - |
| I, GCK1 | 5 | P91 | P77 | R8 | Y11 | 455 |
| V _{CCO} | 5 | P90 | P78 | V _{CCO} Bank 5* | V _{CCO} Bank 5* | - |
| V _{CCO} | 4 | P90 | P78 | V _{CCO} Bank 4* | V _{CCO} Bank 4* | - |
| GND | - | P89 | P79 | GND* | GND* | - |
| I, GCK0 | 4 | P88 | P80 | N8 | W12 | 456 |
| I/O | 4 | P87 | P81 | N9 | U12 | 460 |
| I/O | 4 | P86 | P82 | R9 | Y12 | 466 |
| I/O | 4 | - | - | N10 | AA12 | 469 |
| I/O | 4 | - | P83 | T9 | AB13 | 472 |
| I/O, V _{REF} | 4 | P85 | P84 | P9 | AA13 | 475 |
| GND | - | - | P85 | GND* | GND* | - |
| I/O | 4 | - | P86 | M10 | Y13 | 478 |
| I/O | 4 | - | P87 | R10 | V13 | 481 |
| I/O | 4 | - | P88 | P10 | AA14 | 487 |
| I/O | 4 | - | - | - | V14 | 490 |
| I/O | 4 | P84 | P89 | T10 | AB15 | 493 |
| I/O | 4 | P83 | P90 | R11 | AA15 | 496 |
| V _{CCINT} | - | P82 | P91 | V _{CCINT} * | V _{CCINT} * | - |
| V _{CCO} | 4 | - | P92 | V _{CCO} Bank 4* | V _{CCO} Bank 4* | - |
| GND | - | P81 | P93 | GND* | GND* | - |
| I/O | 4 | P80 | P94 | M11 | Y15 | 499 |

XC2S150 Device Pinouts

| XC2S150 Pad Name | | PQ208 | FG256 | FG456 | Bndry Scan |
|-----------------------|------|-------|--------------------------|--------------------------|------------|
| Function | Bank | | | | |
| GND | - | P1 | GND* | GND* | - |
| TMS | - | P2 | D3 | D3 | - |
| I/O | 7 | P3 | C2 | B1 | 221 |
| I/O | 7 | - | - | E4 | 224 |
| I/O | 7 | - | - | C1 | 227 |
| I/O | 7 | - | A2 | F5 | 230 |
| GND | - | - | GND* | GND* | - |
| I/O | 7 | P4 | B1 | D2 | 233 |
| I/O | 7 | - | - | E3 | 236 |
| I/O | 7 | - | - | F4 | 239 |
| I/O | 7 | - | E3 | G5 | 242 |
| I/O | 7 | P5 | D2 | F3 | 245 |
| GND | - | - | GND* | GND* | - |
| V _{CCO} | 7 | - | V _{CCO} Bank 7* | V _{CCO} Bank 7* | - |
| I/O, V _{REF} | 7 | P6 | C1 | E2 | 248 |
| I/O | 7 | P7 | F3 | E1 | 251 |
| I/O | 7 | - | - | G4 | 254 |
| I/O | 7 | - | - | G3 | 257 |
| I/O | 7 | - | E2 | H5 | 260 |
| I/O | 7 | P8 | E4 | F2 | 263 |
| I/O | 7 | - | - | F1 | 266 |
| I/O, V _{REF} | 7 | P9 | D1 | H4 | 269 |
| I/O | 7 | P10 | E1 | G1 | 272 |
| GND | - | P11 | GND* | GND* | - |
| V _{CCO} | 7 | P12 | V _{CCO} Bank 7* | V _{CCO} Bank 7* | - |
| V _{CCINT} | - | P13 | V _{CCINT} * | V _{CCINT} * | - |
| I/O | 7 | P14 | F2 | H3 | 275 |
| I/O | 7 | P15 | G3 | H2 | 278 |
| I/O | 7 | - | - | H1 | 284 |
| I/O | 7 | - | F1 | J5 | 287 |
| I/O | 7 | P16 | F4 | J2 | 290 |
| I/O | 7 | - | - | J3 | 293 |
| I/O | 7 | P17 | F5 | K5 | 299 |
| I/O | 7 | P18 | G2 | K1 | 302 |
| GND | - | P19 | GND* | GND* | - |
| V _{CCO} | 7 | - | V _{CCO} Bank 7* | V _{CCO} Bank 7* | - |
| I/O, V _{REF} | 7 | P20 | H3 | K3 | 305 |
| I/O | 7 | P21 | G4 | K4 | 308 |
| I/O | 7 | - | H2 | L6 | 311 |

XC2S150 Device Pinouts (Continued)

| XC2S150 Pad Name | | PQ208 | FG256 | FG456 | Bndry Scan |
|--------------------------|------|-------|--------------------------|--------------------------|------------|
| Function | Bank | | | | |
| I/O | 7 | P22 | G5 | L1 | 314 |
| I/O | 7 | - | - | L5 | 317 |
| I/O | 7 | P23 | H4 | L4 | 320 |
| I/O, IRDY ⁽¹⁾ | 7 | P24 | G1 | L3 | 323 |
| GND | - | P25 | GND* | GND* | - |
| V _{CCO} | 7 | P26 | V _{CCO} Bank 7* | V _{CCO} Bank 7* | - |
| V _{CCO} | 6 | P26 | V _{CCO} Bank 6* | V _{CCO} Bank 6* | - |
| I/O, TRDY ⁽¹⁾ | 6 | P27 | J2 | M1 | 326 |
| V _{CCINT} | - | P28 | V _{CCINT} * | V _{CCINT} * | - |
| I/O | 6 | - | - | M6 | 332 |
| I/O | 6 | P29 | H1 | M3 | 335 |
| I/O | 6 | - | J4 | M4 | 338 |
| I/O | 6 | P30 | J1 | M5 | 341 |
| I/O, V _{REF} | 6 | P31 | J3 | N2 | 344 |
| V _{CCO} | 6 | - | V _{CCO} Bank 6* | V _{CCO} Bank 6* | - |
| GND | - | P32 | GND* | GND* | - |
| I/O | 6 | P33 | K5 | N3 | 347 |
| I/O | 6 | P34 | K2 | N4 | 350 |
| I/O | 6 | - | - | N5 | 356 |
| I/O | 6 | P35 | K1 | P2 | 359 |
| I/O | 6 | - | K3 | P4 | 362 |
| I/O | 6 | - | - | R1 | 365 |
| I/O | 6 | P36 | L1 | P3 | 371 |
| I/O | 6 | P37 | L2 | R2 | 374 |
| V _{CCINT} | - | P38 | V _{CCINT} * | V _{CCINT} * | - |
| V _{CCO} | 6 | P39 | V _{CCO} Bank 6* | V _{CCO} Bank 6* | - |
| GND | - | P40 | GND* | GND* | - |
| I/O | 6 | P41 | K4 | T1 | 377 |
| I/O, V _{REF} | 6 | P42 | M1 | R4 | 380 |
| I/O | 6 | - | - | T2 | 383 |
| I/O | 6 | P43 | L4 | U1 | 386 |
| I/O | 6 | - | M2 | R5 | 389 |
| I/O | 6 | - | - | V1 | 392 |
| I/O | 6 | - | - | T5 | 395 |
| I/O | 6 | P44 | L3 | U2 | 398 |
| I/O, V _{REF} | 6 | P45 | N1 | T3 | 401 |
| V _{CCO} | 6 | - | V _{CCO} Bank 6* | V _{CCO} Bank 6* | - |
| GND | - | - | GND* | GND* | - |

XC2S200 Device Pinouts (Continued)

| XC2S200 Pad Name | | PQ208 | FG256 | FG456 | Bndry Scan |
|-----------------------|------|-------|--------------------------|--------------------------|------------|
| Function | Bank | | | | |
| GND | - | P198 | GND* | GND* | - |
| I/O | 0 | P199 | A5 | B7 | 188 |
| I/O, V _{REF} | 0 | P200 | C6 | E8 | 191 |
| I/O | 0 | - | - | D8 | 197 |
| I/O | 0 | P201 | B5 | C7 | 200 |
| GND | - | - | GND* | GND* | - |
| I/O | 0 | - | D6 | D7 | 203 |
| I/O | 0 | - | - | B6 | 206 |
| I/O | 0 | - | - | A5 | 209 |
| I/O | 0 | P202 | A4 | D6 | 212 |
| I/O, V _{REF} | 0 | P203 | B4 | C6 | 215 |
| V _{CCO} | 0 | - | V _{CCO} Bank 0* | V _{CCO} Bank 0* | - |
| GND | - | - | GND* | GND* | - |
| I/O | 0 | P204 | E6 | B5 | 218 |
| I/O | 0 | - | D5 | E7 | 221 |
| I/O | 0 | - | - | A4 | 224 |
| I/O | 0 | - | - | E6 | 230 |
| I/O, V _{REF} | 0 | P205 | A3 | B4 | 233 |
| GND | - | - | GND* | GND* | - |
| I/O | 0 | - | C5 | A3 | 236 |
| I/O | 0 | - | - | B3 | 239 |
| I/O | 0 | - | - | D5 | 242 |
| I/O | 0 | P206 | B3 | C5 | 248 |
| TCK | - | P207 | C4 | C4 | - |
| V _{CCO} | 0 | P208 | V _{CCO} Bank 0* | V _{CCO} Bank 0* | - |
| V _{CCO} | 7 | P208 | V _{CCO} Bank 7* | V _{CCO} Bank 7* | - |

04/18/01

Notes:

1. IRDY and TRDY can only be accessed when using Xilinx PCI cores.
2. Pads labelled GND*, V_{CCINT}*, V_{CCO} Bank 0*, V_{CCO} Bank 1*, V_{CCO} Bank 2*, V_{CCO} Bank 3*, V_{CCO} Bank 4*, V_{CCO} Bank 5*, V_{CCO} Bank 6*, V_{CCO} Bank 7* are internally bonded to independent ground or power planes within the package.
3. See "V_{CCO} Banks" for details on V_{CCO} banking.

Additional XC2S200 Package Pins

PQ208

| Not Connected Pins | | | | | |
|--------------------|-----|---|---|---|---|
| P55 | P56 | - | - | - | - |

11/02/00

FG256

| V _{CCINT} Pins | | | | | |
|------------------------------|-----|-----|-----|----|-----|
| C3 | C14 | D4 | D13 | E5 | E12 |
| M5 | M12 | N4 | N13 | P3 | P14 |
| V _{CCO} Bank 0 Pins | | | | | |
| E8 | F8 | - | - | - | - |
| V _{CCO} Bank 1 Pins | | | | | |
| E9 | F9 | - | - | - | - |
| V _{CCO} Bank 2 Pins | | | | | |
| H11 | H12 | - | - | - | - |
| V _{CCO} Bank 3 Pins | | | | | |
| J11 | J12 | - | - | - | - |
| V _{CCO} Bank 4 Pins | | | | | |
| L9 | M9 | - | - | - | - |
| V _{CCO} Bank 5 Pins | | | | | |
| L8 | M8 | - | - | - | - |
| V _{CCO} Bank 6 Pins | | | | | |
| J5 | J6 | - | - | - | - |
| V _{CCO} Bank 7 Pins | | | | | |
| H5 | H6 | - | - | - | - |
| GND Pins | | | | | |
| A1 | A16 | B2 | B15 | F6 | F7 |
| F10 | F11 | G6 | G7 | G8 | G9 |
| G10 | G11 | H7 | H8 | H9 | H10 |
| J7 | J8 | J9 | J10 | K6 | K7 |
| K8 | K9 | K10 | K11 | L6 | L7 |
| L10 | L11 | R2 | R15 | T1 | T16 |
| Not Connected Pins | | | | | |
| P4 | R4 | - | - | - | - |